

Application/Control No.	Applicant(s)/Patent under Reexamination
10/044,195	SYED, MAJID
Examiner	Art Unit
Thuong (Tina) T. Nguyen	2155

	SEARCHED				
Class	Subclass	Date	Examiner		
709	225,235, 231	9/29/2008	тн		
725	85	9/29/2008	TH		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEAI	NOTES RCH STRATEGY	
	DATE	EXMR
EAST	9/29/2008	тн
IEEE	9/29/2008	ТН